


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/068,433	PO ET AL.	
	Examiner	Art Unit	
	Leith A. Al-Nazer	2821	

ISSUE CLASSIFICATION									
ORIGINAL					CROSS REFERENCE(S)				
CLASS	SUBCLASS				CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)			
372	6				372	3	92	102	
INTERNATIONAL CLASSIFICATION									
H	0	1	S	3/30					
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<i>Leith A. Al-Nazer</i> 4/20/05 (Assistant Examiner) (Date)	<i>Don Wong</i> Supervisory Patent Examiner Technology Center 2800 5/1/05 (Date)	Total Claims Allowed: 31 O.G. Print Claim(s) 1 O.G. Print Fig. 1
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<input type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA				<input type="checkbox"/> T.D.				<input type="checkbox"/> R.1.47			
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